

TPC8053-H-VB Datasheet N-Channel 60-V (D-S) MOSFET

PRODUCT SUMMARY					
V _{DS} (V)	R _{DS(on)} (Ω)	I _D (A) ^d	Q _g (Typ.)		
60	0.012 at V _{GS} = 10 V	12	10.5 nC		
00	0.015 at V _{GS} = 4.5 V	11	10.5110		



- Halogen-free According to IEC 61249-2-21
 Definition
- Trench Power MOSFET
- Optimized for "Low Side" Synchronous Rectifier Operation



Available

100 % R_g and UIS Tested

APPLICATIONS

CCFL Inverter

	SO-8		D Q
S 1 S 2 S 3 G 4		8 D 7 D 6 D 5 D	G Q L L L L L L L L L L L L L L L L L L
	Top View		N-Channel MOSFET

ABSOLUTE MAXIMUM RATINGS T Parameter	Symbol	Limit	Unit		
Drain-Source Voltage		V _{DS}	60	V	
Gate-Source Voltage		V _{GS}	± 20		
	T _C = 25 °C		12 ^a		
Continuous Drain Current (T_{1} = 150 °C)	T _C = 70 °C		11		
Continuous Drain Current $(1) = 150^{\circ} C$	T _A = 25 °C	I _D	8.0 ^{b, c}		
	T _A = 70 °C		7.6 ^{b, c}		
Pulsed Drain Current	I _{DM}	25	Α		
	T _C = 25 °C	1	4.2		
Continuous Source-Drain Diode Current	T _A = 25 °C	I _S	2.1 ^{b, c}		
Avalanche Current		I _{AS}	15		
Single-Pulse Avalanche Energy	L = 0.1 mH	E _{AS}	11.2	mJ	
	T _C = 25 °C		5		
Maximum Power Dissipation	T _C = 70 °C		3.2	w	
	T _A = 25 °C	– P _D –	2.5 ^{b, c}	vv	
	T _A = 70 °C	1	1.6 ^{b, c}		
Operating Junction and Storage Temperature Range	T _J , T _{stg}	- 55 to 150	°C		

THERMAL RESISTANCE RATINGS						
Parameter		Symbol	Typical	Maximum	Unit	
Maximum Junction-to-Ambient ^{b, d}	t ≤ 10 s	R _{thJA}	38	50	°C/W	
Maximum Junction-to-Foot (Drain)	Steady State	R _{thJF}	20	25	°C/vv	

Notes:

a. Package limited.

b. Surface mounted on 1" x 1" FR4 board.

c. t = 10 s.

d. Maximum under Steady State conditions is 85 °C/W.



Parameter	Symbol	Test Conditions	Min.	Тур.	Max.	Unit	
Static							
Drain-Source Breakdown Voltage	V _{DS}	V _{GS} = 0 V, I _D = 250 μA	60			V	
V _{DS} Temperature Coefficient	$\Delta V_{DS}/T_{J}$	L 050 mA		55		200	
V _{GS(th)} Temperature Coefficient	$\Delta V_{GS(th)}/T_J$	I _D = 250 μA		- 6.3		mV/°C	
Gate-Source Threshold Voltage	V _{GS(th)}	$V_{DS} = V_{GS}, I_{D} = 250 \ \mu A$	1.0		3.0	V	
Gate-Source Leakage	I _{GSS}	$V_{DS} = 0 V, V_{GS} = \pm 20 V$			± 100	nA	
	I _{DSS}	$V_{DS} = 60 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			1	μΑ	
Zero Gate Voltage Drain Current		V _{DS} = 60 V, V _{GS} = 0 V, T _J = 55 °C			10		
On-State Drain Current ^a	I _{D(on)}	$V_{DS} \ge 5 V$, $V_{GS} = 10 V$	25			А	
		V _{GS} = 10 V, I _D = 4.6 A		0.012		Ω	
Drain-Source On-State Resistance ^a	R _{DS(on)}	$V_{GS} = 4.5 \text{ V}, I_{D} = 4.2 \text{ A}$		0.015			
Forward Transconductance ^a	9 _{fs}	V _{DS} = 15 V, I _D = 4.6 A		20		S	
Dynamic ^b							
Input Capacitance	C _{iss}			1100			
Output Capacitance	C _{oss}	V _{DS} = 30 V, V _{GS} = 0 V, f = 1 MHz		90		pF	
Reverse Transfer Capacitance	C _{rss}			55			
Total Gate Charge	Qg	$V_{DS} = 30$ V, $V_{GS} = 10$ V, $I_D = 4.6$ A		21	32	nC	
				10.5	16		
Gate-Source Charge	Q _{as}	$V_{DS} = 30$ V, $V_{GS} = 4.5$ V, $I_{D} = 4.6$ A		3.5			
Gate-Drain Charge	Q _{gd}			4.2			
Gate Resistance	R _g	f = 1 MHz		3.3	5	Ω	
Turn-On Delay Time	t _{d(on)}			20	30		
Rise Time	t _r	V_{DD} = 30 V, R_{L} = 5.4 Ω		150	225	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 5.6 \text{ A}, \text{ V}_{\text{GEN}} = 4.5 \text{ V}, \text{ R}_{\text{g}} = 1 \Omega$		20	30		
Fall Time	t _f			60	90		
Turn-On Delay Time	t _{d(on)}			10	15	ns	
Rise Time	t _r	V_{DD} = 30 V, R_{L} = 5.4 Ω		15	25	-	
Turn-Off DelayTime	t _{d(off)}	$I_D \cong 5.6 \text{ A}, \text{ V}_{\text{GEN}} = 10 \text{ V}, \text{ R}_{\text{q}} = 1 \Omega$		25	40		
Fall Time	t _f			10	15		
Drain-Source Body Diode Characterist	ics			1			
Continous Source-Drain Diode Current	۱ _s	T _C = 25 °C			4.2		
Pulse Diode Forward Current ^a	I _{SM}			İ	25	A	
Body Diode Voltage	V _{SD}	I _S = 2 A		0.8	1.2	V	
Body Diode Reverse Recovery Time	t _{rr}	~		25	50	ns	
Body Diode Reverse Recovery Charge	Q _{rr}			25	50	nC	
Reverse Recovery Fall Time	t _a	I _F = 5.5 A, dl/dt = 100 A/μs, T _J = 25 °C		19			
verse Recovery Rise Time t _b			6		ns		

Notes:

a. Pulse test; pulse width \leq 300 $\mu s,$ duty cycle \leq 2 %.

b. Guaranteed by design, not subject to production testing.

Stresses beyond those listed under "Absolute Maximum Ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of the specifications is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.



 $T_C =$ - 55

I_D = 25 °C

2.0

Ciss

30

50

75

100

125

40

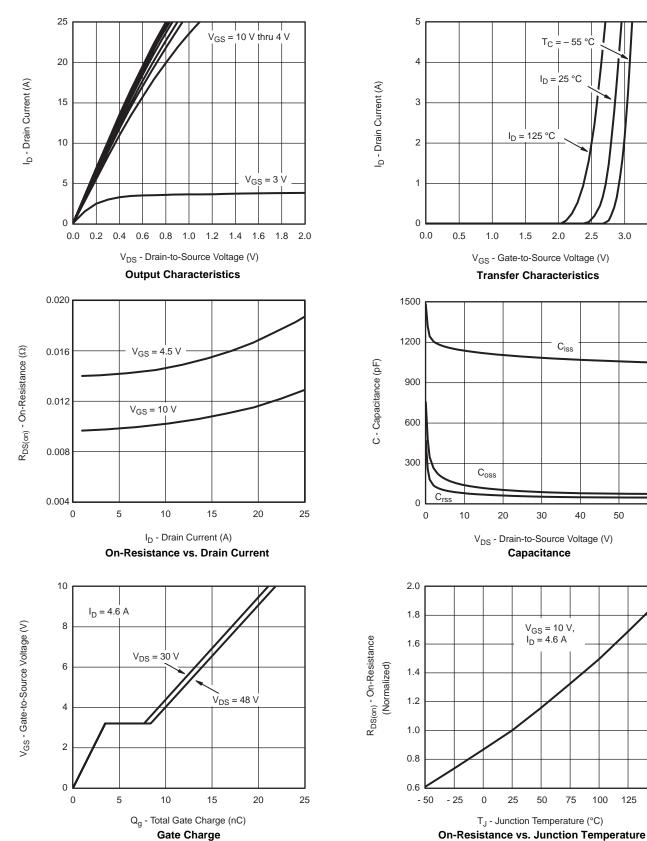
50

60

2.5

3.0

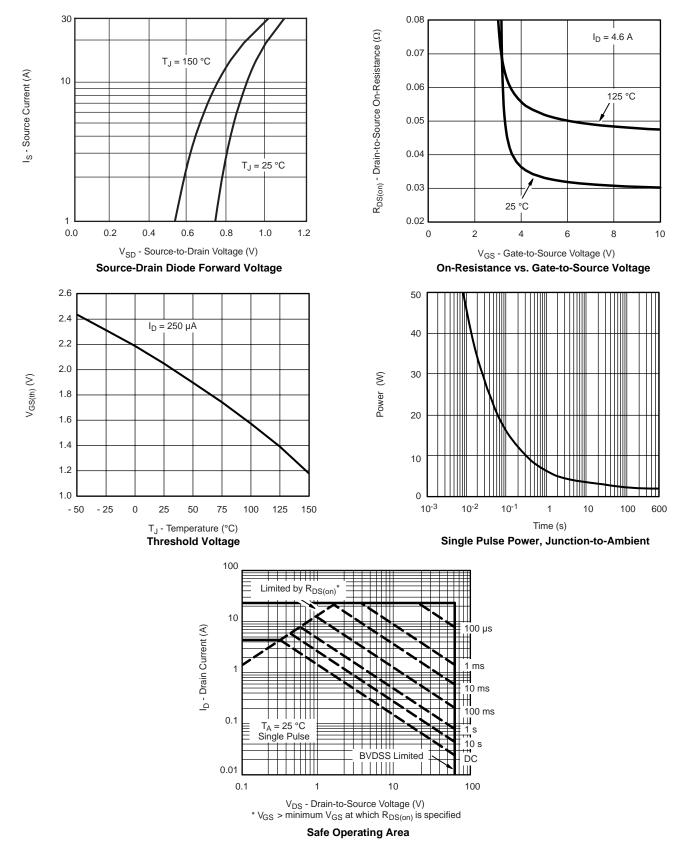
3.5



TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

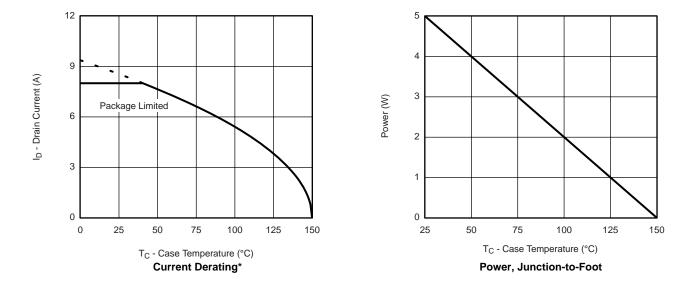
150





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

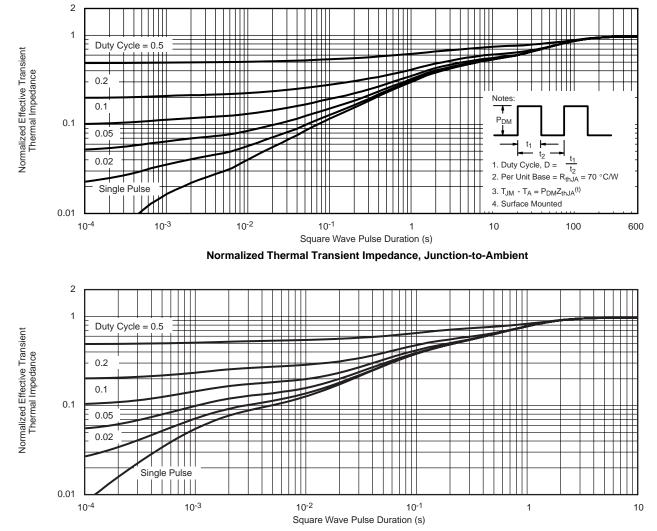




TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

* The power dissipation P_D is based on $T_{J(max)}$ = 150 °C, using junction-to-case thermal resistance, and is more useful in settling the upper dissipation limit for cases where additional heatsinking is used. It is used to determine the current rating, when this rating falls below the package limit.





TYPICAL CHARACTERISTICS 25 °C, unless otherwise noted

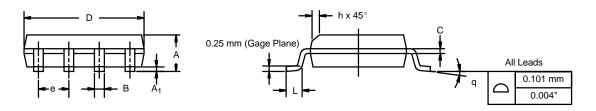
Normalized Thermal Transient Impedance, Junction-to-Foot



SOIC (NARROW): 8-LEAD

JEDEC Part Number: MS-012





	MILLIMETERS		INC	HES	
DIM	Min	Мах	Min	Max	
A	1.35	1.75	0.053	0.069	
A ₁	0.10	0.20	0.004	0.008	
В	0.35	0.51	0.014	0.020	
С	0.19	0.25	0.0075	0.010	
D	4.80	5.00	0.189	0.196	
E	3.80	4.00	0.150	0.157	
е	1.27	BSC	0.050 BSC		
н	5.80	6.20	0.228	0.244	
h	0.25	0.50	0.010	0.020	
L	0.50	0.93	0.020	0.037	
q	0°	8°	0°	8°	
S	0.44	0.64	0.018	0.026	
ECN: C-06527-Rev. I, 11-Sep-06 DWG: 5498					



RECOMMENDED MINIMUM PADS FOR SO-8



Recommended Minimum Pads Dimensions in Inches/(mm)



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